Search Notes

Application/Control No.	Applicant(s)/Patent under R examination	
10/769,929	PARK et al.	
Examiner	Art Unit	
Lee, Calvin	2818	5649-1230

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	300-306 310, 760	9/8/2005	CL
438	240, 253	#	#
#	396, 680	#	#
#	761-763	#	#

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCI	H STRATEGY)
	DATE	EXMR
Keyword Search EAST 438/240	9/12/2005	CL
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